The Effect of Low-Amplitude Oscillations of the Load on the Local Stiffness of Materials in Loaded Nanocontacts Detected by Methods of Dynamic Nanoindentation

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Abstract

The role of low-amplitude oscillations in the formation of mechanical properties of nanocontacts with different values of the ratio of hardness H to the elastic modulus E was studied by dynamic nanoindentation (DNI). Various methods for processing raw data and extracting nanocontact characteristics from them have different sensitivity to low-amplitude oscillations of the load. It is found that under certain test conditions, the addition of low-amplitude oscillations does not affect the mechanisms, kinetics and magnitude of the plastic deformation of the material under the indenter. The threshold values of the oscillation amplitude for materials to soften locally in the nanocontact interaction are determined.

Keywords

Nanocontact harmonic stiffness; dynamic nanoindentation; low-amplitude oscillations; acoustoplastic effect.

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Introduction

Due to the complexity of the physicochemical processes occurring in dynamic nanocontacts during dry friction, wear, grinding, etc., the regularities and atomic deformation mechanisms under these conditions remain unclear. The desire to increase the amount of information about the behavior of the material in dynamic nanocontacts and thin near-surface layers initiated the invention and the subsequent development of an innovative instrumental option of nanoindentation (NI) – continuous stiffness measurement (CSM). The principle of the CSM mode is to superimpose low-amplitude harmonic perturbation $F_{osc} = F_a \sin \omega t$, on the initial slowly growing load $F(t)$, where F_a is amplitude of additional harmonic force, ω is its cyclic frequency (Fig. 1). Sometimes this method is called dynamic nanoindentation (DNI) and is realized with both prismatic and spherical indenters [1–5]. The CSM option allows one to study mechanical characteristics in films with a thickness from one nanometer to many microns, in separate phases of composite materials, multilayer coatings and macrohomogeneous samples, when the size of the locally deformed region changes

by 4–5 orders of magnitude (the volume of material involved into deformation increases up to 15 orders of magnitude!) [6].

Fig. 1. Typical load profile used in the work:
1 – loading curve; 2 – constant load; 3 – unloading;
4 – temperature drift detection (On the inset – the principle of the CSM mode. Here Z_{Re} and Z_{Im} are the real and imaginary parts of displacement oscillations)

The CSM makes it possible to study indentation size effects (ISE) during a single test cycle [7], to conduct hundreds of tests on the resistance of plastic deformation and fatigue in a nanoscale on one sample to collect reliable statistics, to measure wear resistance of individual parts of micro- and nanomechanical systems (MEMS / NEMS), to investigate the visco-elastic properties of biomolecular objects (for example, healthy and cancer cells), atomic mechanisms of constrained local deformation [8–10] and much more. Thus, at the scale, the CSM occupies an intermediate position between the AFM methods, with the size of the test region ~ 1 nm, and the macroscopic methods of dynamic mechanical analysis (DMA) and internal friction (IF), but in nature and in the principle of implementation is a local analogue of the latter [11–13].

Earlier, we found the existence of some critical amplitude of load / deformation oscillations, at which the atomic structure of the material does not undergo additional irreversible changes and practically does not dissipate the elastic energy during the test [14]. Such “non-destructive” tests are reliable only up to a certain critical value of the amplitude of the oscillations. In the supercritical modes, an irreversible rearrangement of the initial structure begins (for example, the multiplication of dislocations, their movement over large distances, changes in the structure of subgrain and grain boundaries, etc.). It is known that simultaneous action of a relatively slowly increasing load and an additional supercritical oscillatory force causes the acoustoplastic effect (APE), expressed in decreasing the yield strength, the strain hardening coefficient, etc. [15–17]. Analogous phenomena can also be expected in dynamic nanoindentation.

Along with the effect of the harmonic load on the defect structure of the material, the methodological errors of the CSM method [3–5, 18, 19] could be mentioned as a possible cause of the usually observed softening at the contact spot under the influence of oscillations. However, the amount of available data on atomic mechanisms and the impact of oscillations on the behavior of dynamic contacts are still insufficient, so that reliability and consistency of DNI results are questionable. For example, Cordill et al. [20] suggested that the periodic action of low-frequency low-amplitude oscillations can cause material fatigue in the nanocontact, that is, modify the mechanical properties of the sample under study in the contact spot. This hypothesis has been experimentally confirmed [8, 21], however, only at much larger oscillation amplitudes than is commonly used in nanoindentation. Another problem of DNI is the observed discrepancy between dynamic and quasi-statistic tests at very small

indentation depths [22, 23]. Later they were taken into account, and it was shown in [19] that for materials with a Young's modulus to hardness ratio (E/H) > 10 , the assumption of a unloading linearity is not fully satisfied for oscillations whose amplitude is more than a few nanometers, which leads to systematic overestimation of the stiffness.

The identified problems allow us to formulate the goals and objectives of this study as follows:

- a) finding the range of loads / deformations at which the CSM method does not affect the mechanisms, kinetics and magnitude of localized plastic deformation under the indenter, for materials having a Young's modulus to hardness ratio (E/H) > 10 ;
- b) determining quantitative regularities of the discrepancy between dynamic measurements and quasi-statistical tests at very small indentation depths in materials with various E/H ratios.

Equipment, materials and preparation of samples

The experimental part of the work was performed using Agilent's NanoIndenter® G200 instrument in the load range of 0.01–100 mN using a Berkovich diamond indenter having tip radius $R = 20$ nm. The testing was carried out by two main loading modes: a) traditional quasi-static without adding oscillations; b) using the CSM method with superposition of an additional oscillation of the indenter displacement in the direction perpendicular to the test surface, with amplitude $z = 0.5$ –8 nm and frequency 10–45 Hz. During all the experiments, the rate of relative quasistatic deformation was kept constant $\dot{\epsilon} = 0.05$ s⁻¹ by means of feedback circuits in the instrument, which made it possible to exclude the effect of the loading rate factor on the hardness value. The maximum depth of prints in the control samples (for which $z = 0$), preset in the test report was 25, 50, 100, 200, 500, 1000, 1500 and 2000 nm. All prints were located at a distance of at least 50 μ m from each other in order to avoid their mutual influence. The hardness values of H and the Young's modulus E were averaged from the data of ten prints.

As research objects, several representatives of different classes of materials were selected, which differ in the magnitude of the ratio E/H :

- a) high-purity (0.9999 wt %) polycrystalline (average grain size ~ 100 μ m) soft and plastic ($E/H = 240$) metal with face-centered cubic (fcc) lattice (Al);
- b) hard metal with body-centered cubic lattice (bcc) W ($E/H = 70$);
- c) rigid semiconductor GaAs ($E/H = 14$).

The surface of polycrystalline Al samples with dimensions $10 \times 10 \times 3$ mm³ was prepared by mechanical grinding with SiC abrasive (1200 grit) and polishing with diamond paste on the Buehler Vector

Power Grid device for sample preparation. After mechanical polishing, the surface layer was electrochemically polished for 3 minutes at a current density 1 A/cm^2 in 10 % HCl solution in ethanol to eliminate the near-surface deformation-hardened layer.

Non-doped samples of single-crystal GaAs (99.999 %, Sigma Aldrich) with orientation (001) were cut in the form of a parallelepiped of $10 \times 5 \times 1 \text{ mm}^3$ and were subsequently polished with Al_2O_3 powder with a particle size of 5, 1 and $0.3 \text{ }\mu\text{m}$.

Polycrystalline samples of tungsten ($6 \times 12 \times 3 \text{ mm}^3$; 99.97 % purity, average grain size 30 microns) were made by melting a large ingot in an inert gas atmosphere. Samples were also polished in a standard manner using the Buehler Vector Power Grid to a mirror finish. The final surface roughness of the samples was measured by the AFM method in the “tapping mode” at a site of $4 \text{ }\mu\text{m}^2$. The root mean square roughness value for all samples did not exceed 2 nm.

The basic nanocontact characteristics – hardness H and Young’s modulus E were calculated in four different ways: 1) by the Oliver-Pharr Method (OPM) [1, 2, 24]; 2) by the CSM method [1–7, 25]; 3) by the OPM method [1, 2, 25] from the analysis of the unloading branch of the P - h diagram near P_{max} and 4) by direct measurement of the area of the projection A_c of the print in an atomic force microscope [26]. In greater detail, the method for calculating the nanocontact characteristics is given in [14].

Experimental results

Materials with a high ratio (E/H) are characterized by a strong deviation from the linearity of the unloading branch of the loading diagram [3, 4, 7, 19, 24, 25]. For most ceramics and metals, the value of E/H varies between 10–300. In accordance with this, the shape of the unloading curve also changes significantly. Experimentally the value of harmonic contact stiffness S_H and harmonic contact damping D_i of the test material can be calculated from the analysis of the dynamic response of the system:

$$1/S_H = 1/((K_i - m\omega^2)^2 + (D_i\omega)^2)^{0.5}, \quad (1)$$

where K_i is suspension spring stiffness, m is weight of the moving parts of the measuring head, ω is oscillation circular frequency. The value of the elastic and damping constants of the device is known: $K_i = 92.02 \text{ N/m}$, $m_i = 11.6 \text{ g}$, $D_i = 2.66 \text{ N}\cdot\text{s/m}$, which allows finding the values of H and E by standard OPM [1, 2, 25]. In the paper, the dependences of both the

standard stiffness $S = dP/dh$ in the absence of oscillations (here P is the magnitude of the load on the indenter, h is the depth of indenter introduction) in the nacontact, and harmonic stiffness S_H on the ratio E/H have been studied.

As follows from the graphs of the dependence of the harmonic stiffness S_H in the contact of the indenter with the sample on the indenter penetration depth h for different amplitudes of the additional oscillations z shown in Fig. 2, the largest value of S_H has a tungsten – refractory metal with a bcc lattice with $E/H = 70$. The minimum S_H of the tested materials has fcc aluminum metal for which $E/H = 240$.

For harmonic oscillations in Al, it can be noted that stiffness has the greatest value for each of the materials studied in the absence of oscillations, and harmonic oscillations of displacement above some critical amplitude cause softening of the material in the dynamic nanocontact. Al is the only material in which the dependence of the harmonic stiffness on the amplitude of the additional oscillations z becomes observable, which coincides with the known literature data [23, 27]. For W and GaAs, the amplitude of the additional stiffness oscillations lies within the measurement uncertainty.

According to the literature data for the spherical indenter [9], it is known that the measured contact stiffness depends strongly not only on the amplitude, but also on the frequency of the additional oscillations used in the experiment. Fig. 3 shows the dependence of the harmonic stiffness on the oscillation frequency in the materials under investigation for the sharp Berkovich indenter for fixed oscillation amplitude $z = 2 \text{ nm}$. As could be seen from this figure, the lower the frequency of the harmonic oscillations, the less is

Fig. 2. Correlation of harmonic stiffness in the contact of the indenter with the sample and the depth of indentation for various amplitudes of harmonic displacement

Fig. 3. Correlation of contact stiffness and the depth of indentation for various frequencies of harmonic oscillations and amplitude of oscillations $z = 2$ nm

the contact stiffness in the investigated frequency range.

It can also be stated that the smallest angle with the stiffness axis is the family of curves $S_H(\omega)$ for W, the largest one is for Al, and GaAs occupies an intermediate position between them. It is not yet possible to explain why, for a metal with a bcc lattice, the harmonic stiffness curves with respect to frequency are separated most clearly and much better than for fcc metals. For all materials, the following general rule is fulfilled – the increase in rigidity occurs linearly with increasing h to a certain critical value, starting from which the stiffening growth curves diverge. For W this difference is more pronounced than for Al, whereas for GaAs it does not go beyond the measurement error.

As was established in our work [14] earlier, the value of the main load P , necessary for imprinting the indenter to a fixed depth, consistently decreased with increasing amplitude of displacement oscillations. Hence, for a fixed load the superposition of additional oscillations should lead to an increase of indentation depth h with increasing z . As a measure of the effect of superimposed oscillations on the local deformation under the indenter, it was also proposed to take the depth difference δh between the loading curves with the addition of additional oscillation of the displacement ($z > 0$), and without it ($z = 0$) at each point with the same load P . This allows us to take the value of δh as a quantitative characteristic of the additional deformation under the influence of oscillations. The observed values of additional deformation δh in the presence of additional harmonic oscillation grow with increasing E/H (Fig. 4).

We can note a small value of δh at the initial stage of indentation. Perhaps this is a consequence of the fact that at the initial stage of the interaction of the indenter

Fig. 4. The value of the additional deformation under the influence of the oscillating load at different penetration depths of the indenter for materials with different value of the ratio E/H

with the surface of the sample, the response of the system for determining the moment of contact and the zero point for indentation depth recording can be added to the response of the material. A sudden change in stiffness in the case of a short-term contact of oscillating indenter with the sample surface should lead to the activation of feedback loops and an increase in the amplitude of the oscillations, and the discontinuity of the contact to the inverse process. These transient processes can increase the error in determining the position of the surface. However, after the establishing steady (uninterrupted) contact, the role of this factor should decrease with increasing h .

Analysis of the ratio of the change in hardness $\Delta H/H$ when the indenter is loaded with the addition of oscillation of the displacement to the hardness determined by the OPM method without imposing oscillation, on the value of the ratio E/H for indenting a single crystal of gallium arsenide and polycrystals W and Al indicates that the quantity $\Delta H/H < 0$ under any conditions (Fig. 5).

Finally, for each material studied in this paper, the limiting amplitude of the critical vibrations z_c (i.e., the amplitude of the harmonic oscillations, not causing a noticeable effect on the microstructure of the material) was determined. Fig. 6 shows the dependence of z_c on the ratio E/H . The value of z_c can reach 3.5 nm for GaAs single crystals, whereas for the W polycrystals the critical amplitude never exceeds 3 nm. The observed amplitude of critical oscillations for Al is 2 nm, which is close to the critical threshold z_c^*

Fig. 5. Dependence of the relative hardness $\Delta H/H$ for materials with different values of E/H for different values of the contact depth h_c and the oscillation amplitude in the range 0.5–8 nm

Fig. 6. Dependence of the critical amplitude of harmonic oscillations z_c on the value of the ratio E/H of different materials for different values of the depth of the nanocontact

recommended for CSM measurements in a mode free from systematic hardness overestimation for both spherical and prismatic indenter [18, 19]. To explain this behavior of the material, it can be assumed that the cause of softening is the fatigue of the material in the nanocontact under the action of a large number of cycles of alternating loading [8]. Experimental studies of fatigue in nanocontacts can help to determine the validity of this hypothesis, but they have not been carried out to date.

Conclusion

The studies carried out for materials with different Young's modulus ratio to hardness (E/H) made it possible to establish the following.

1. The harmonic stiffness S_H of the polycrystalline bcc tungsten metal in the contact of the indenter with

the sample proves to be higher than that of the soft and plastic fcc metal Al.

2. It has been found that the softer and more pliable the material is, the more noticeable is the effect of harmonic oscillations of the loading force.

3. The quantitative dependence of the harmonic stiffness on the frequency of oscillations in the materials studied has been revealed. In the frequency range 10–40 Hz, the following rule is fulfilled – the higher the oscillation frequency is, the stronger is its effect on the harmonic stiffness of the nanocontact.

4. For materials with different E/H values, it is shown that the greater the ratio of the modulus of elasticity to hardness is, the greater is the value of the measured additional deformation caused by the oscillations.

5. It has been found that the amplitude of the critical oscillations for GaAs is 3.5 nm, while for W this value is 3 nm, and for Al $z_c = 2$ nm.

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